Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	3	"6959112"	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/29 10:00
S1	19	"556916"	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/23 17:55
S2	701	382/149.ccls.	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/24 14:19
S3	135	S2 and ((master or reference or model or mask) adj pattern)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/24 14:20
S4	40	S3 and (repeat\$3 with pattern)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/24 15:48
S5	20	S4 and (corner or edge)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/24 18:10
S6	6	(US-20070053579-\$).did. or (US-5023917-\$ or US-5513275-\$ or US-5917332-\$ or US-6171737-\$ or US-6873720-\$).did.	US-PGPUB; USPAT	AND	ON	2007/10/24 16:14
S10	21	(semiconductor) and (master with pattern with comparison) and ((edge or side or corner) with pattern)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND .	ON	2007/10/24 18:30

S11	11	S2 and (master adj pattern)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/24 18:54
S12	8	S2 and (corner adj pattern)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/24 18:54
S13	701	382/149.ccls.	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/25 10:00
S14	4	S13 and (pattern with center with corner)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/25 10:17
S15	89	S13 and (align\$3 with pattern)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/25 10:18
S16	. 68	S13 and (align\$3 with pattern) and (semiconductor and (memory or CCD))	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/25 10:23
S17	22	S16 and (corner)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/25 11:11
S18	242	(pattern) and (semiconductor) and (four same (corner and side and center)) and defect and comparison	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND .	ON	2007/10/25 11:12

S19	79	(pattern) and (semiconductor) and (four with (corner and side and center)) and defect and comparison	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/25 11:35
S21	923	(rectangular with pattern with (comparison or align\$3))	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/25 11:39
S22	362	(rectangular with pattern with (comparison or align\$3)) and (semiconductor)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/25 11:39
S23	68	(rectangular with pattern with (comparison or align\$3)) and (semiconductor) and (four with corner)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/25 11:40
S24	50	(rectangular with pattern with (comparison or align\$3)) and (semiconductor) and (four with corner) and (four with side)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/25 11:40
S25	46	(rectangular with pattern with (comparison or align\$3)) and (semiconductor) and (four with corner) and (four with side) and (cent\$3)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/25 11:42
S27	. ;	(rectangular with pattern with (comparison or align\$3)) and (semiconductor) and (four with corner with pattern) and (four with side) and (cent\$3)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/25 11:43
S28	34	(rectangular with pattern with (comparison or align\$3)) and (semiconductor) and (four with corner with pattern) and (four with side with pattern) and (cent\$3)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/25 11:43

S29	33	(rectangular with pattern with (comparison or align\$3)) and (semiconductor) and (four with corner with pattern) and (four with side with pattern) and (cent\$3 with pattern)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/25 12:14
S30		S24 not S29	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/25 12:00
S31	7	(nine with standard adj pattern) and semiconductor	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/25 12:10
S32	- 37 - 37	(rectangular with pattern with (comparison or align\$3)) and (four with corner with pattern) and (four with side with pattern) and (cent\$3 with pattern)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/25 12:14
S33		S32 not S29	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/25 12:14
S34	39519	(two corner comparison pattern)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2007/10/25 12:44
S35	113	(corner comparison pattern)	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	WITH	ON ,	2007/10/25 12:44
S36	23	(corner comparison pattern) and "382".clas.	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB	WITH	ON	2007/10/25 12:44

S37	22	(US-20070053579-\$ or US-20020150286-\$ or US-20020181760-\$ or US-20040023128-\$).did. or (US-5023917-\$ or US-5513275-\$ or US-5917332-\$ or US-6171737-\$ or US-6873720-\$ or US-4056716-\$ or US-4758782-\$ or US-5764793-\$ or US-5774574-\$ or US-6674889-\$ or US-5459795-\$ or US-5608816-\$ or US-6504947-\$ or US-6701004-\$ or US-6760473-\$ or US-6985618-\$ or US-4479145-\$ or US-4532650-\$). did.	US-PGPUB; USPAT	AND	ON	2007/10/25 12:59
S38	3	S37 and (master with pattern) and edge	US-PGPUB; USPAT	AND	ON	2007/10/29 10:56